August 1989 Revised August 2000

### 100329A Low Power Octal ECL/TTL Bidirectional Translator with Register

### **General Description**

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SEMICONDUCTOR

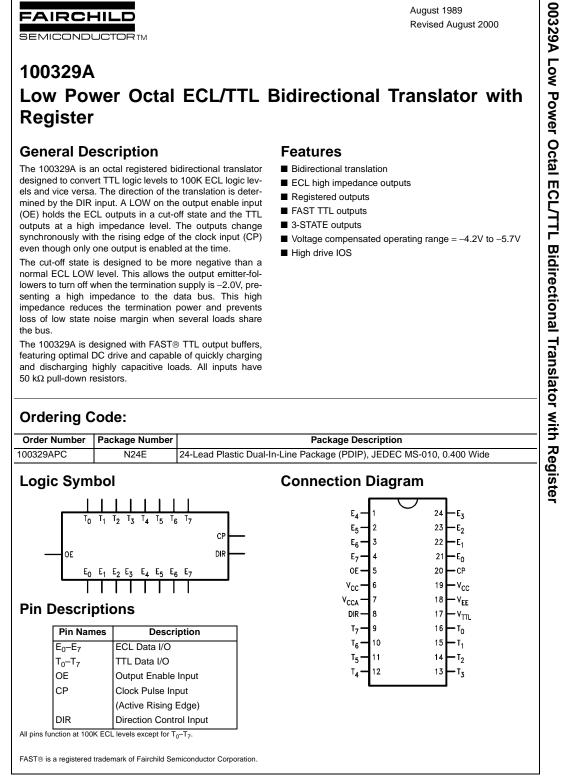
The 100329A is an octal registered bidirectional translator designed to convert TTL logic levels to 100K ECL logic levels and vice versa. The direction of the translation is determined by the DIR input. A LOW on the output enable input (OE) holds the ECL outputs in a cut-off state and the TTL outputs at a high impedance level. The outputs change synchronously with the rising edge of the clock input (CP) even though only one output is enabled at the time.

The cut-off state is designed to be more negative than a normal ECL LOW level. This allows the output emitter-followers to turn off when the termination supply is -2.0V, presenting a high impedance to the data bus. This high impedance reduces the termination power and prevents loss of low state noise margin when several loads share the bus.

The 100329A is designed with FAST® TTL output buffers, featuring optimal DC drive and capable of quickly charging and discharging highly capacitive loads. All inputs have 50 kΩ pull-down resistors.

### **Features**

- Bidirectional translation
- ECL high impedance outputs
- Registered outputs
- FAST TTL outputs
- 3-STATE outputs
- Voltage compensated operating range = -4.2V to -5.7V
- High drive IOS



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### **Truth Table**

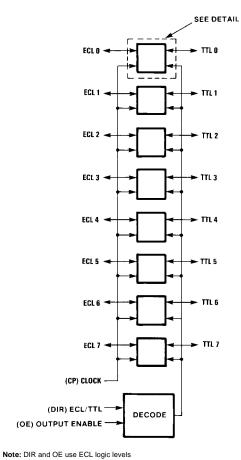
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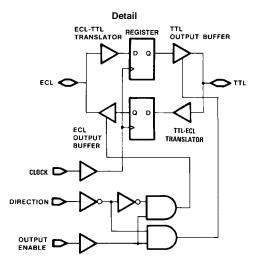
OE	DIR CP		ECL	TTL	Notes
	DIK		Port	Port	Notes
L	L	Х	Input	Z	1, 3
L	Н	Х	LOW	Input	2, 3
			(Cut-Off)		
Н	L	[N]	L	L	1
Н	L	[N]	Н	Н	1
Н	L	L	Х	NC	1, 3
Н	Н	[N]	L	L	2
Н	Н	[N]	Н	Н	2
Н	Н	L	NC	Х	2, 3

H = HIGH Voltage Level

$$\label{eq:constraint} \begin{split} H &= HIGH \ Voltage \ Level \\ L &= LOW \ Voltage \ Level \\ X &= Don't \ Care \\ Z &= High \ Impedance \\ [N] &= LOW-to-HIGH \ Clock \ Transition \\ NC &= No \ Change \end{split}$$

### **Functional Diagram**





Note 1: ECL input to TTL output mode. Note 2: TTL input to ECL output mode. Note 3: Retains data present before CP.

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### Absolute Maximum Ratings(Note 4)

## (Note 4) Recommended Operating Conditions

Storage Temperature (T <sub>STG</sub> )	-65°C to +150°C	Conditions	
Maximum Junction Temperature (T <sub>i</sub> )	+150°C	Case Temperature (T <sub>C</sub> )	0°C to +85°C
V <sub>EE</sub> Pin Potential to Ground Pin	-7.0V to +0.5V	ECL Supply Voltage (V <sub>EE</sub> )	-5.7V to -4.2V
V <sub>TTL</sub> Pin Potential to Ground Pin	-0.5V to +6.0V	TTL Supply Voltage (V <sub>TTL</sub> )	+4.5V to +5.5V
ECL Input Voltage (DC)	V <sub>EE</sub> to +0.5V		
ECL Output Current			
(DC Output HIGH)	–50 mA		
TTL Input Voltage (Note 6)	-0.5V to +6.0V		
TTL Input Current (Note 6)	-30 mA to +5.0 mA		
Voltage Applied to Output		Note 4: The "Absolute Maximum Ratings" a	-
in HIGH State		the safety of the device cannot be guarante operated at these limits. The parametric va	
3-STATE Output	-0.5V to +5.5V	Characteristics tables are not guaranteed at	the absolute maximum rating.
Current Applied to TTL Output		The "Recommended Operating Conditions" for actual device operation.	table will define the conditions
in LOW State (Max)	twice the rated $\mathrm{I}_{\mathrm{OL}}$ (mA)	Note 5: ESD testing conforms to MIL-STD-8	83, Method 3015.
ESD (Note 5)	≥2000V	Note 6: Either voltage limit or current limit is	sufficient to protect inputs.

### TTL-to-ECL DC Electrical Characteristics (Note 7)

 $V_{FF} = -4.2V$  to -5.7V,  $V_{CC} = V_{CCA} = GND$ ,  $T_{C} = 0^{\circ}C$  to +85°C,  $V_{TT1} = +4.5V$  to +5.5V

Symbol	Parameter	Min	Тур	Max	Units	Conditions
V <sub>он</sub>	Output HIGH Voltage	-1025	-955	-870	mV	$V_{IN} = V_{IH}$ (Max) or $V_{IL}$ (Min)
V <sub>OL</sub>	Output LOW Voltage	-1830	-1705	-1620	mV	Loading with $50\Omega$ to $-2V$
	Cutoff Voltage					OE or DIR LOW,
			-2000	-1950	mV	$V_{IN} = V_{IH}$ (Max) or $V_{IL}$ (Min)
						Loading with 50 $\Omega$ to $-2V$
V <sub>онс</sub>	Output HIGH Voltage	-1035			mV	$V_{IN} = V_{IH}$ (Min) or $V_{IL}$ (Max)
	Corner Point HIGH	-1035				Loading with 50 $\Omega$ to $-2V$
V <sub>OLC</sub>	Output LOW Voltage			-1610	mV	7
	Corner Point LOW			-1010	mv	
VIH	Input HIGH Voltage	2.0		5.0	V	Over V <sub>TTL</sub> , V <sub>EE</sub> , T <sub>C</sub> Range
V <sub>IL</sub>	Input LOW Voltage	0		0.8	V	Over V <sub>TTL</sub> , V <sub>EE</sub> , T <sub>C</sub> Range
I <sub>IH</sub>	Input HIGH Current			70	μΑ	V <sub>IN</sub> = +2.7V
	Breakdown Test			1.0	mA	$V_{IN} = +5.5V$
IIL	Input LOW Current	-700			μΑ	$V_{IN} = +0.5V$
V <sub>FCD</sub>	Input Clamp	-1.2			V	I <sub>IN</sub> = -18 mA
	Diode Voltage	-1.2			v	$\eta_{\rm N} = -10$ mA
I <sub>EE</sub>	V <sub>EE</sub> Supply Current					LE LOW, OE and DIR HIGH
						Inputs OPEN
		-189		-94	mA	$V_{EE} = -4.2V$ to $-4.8V$
		-199		-94		V <sub>FF</sub> = -4.2V to -5.7V

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# $\label{eq:constraint} \begin{array}{l} \textbf{ECL-to-TTL DC Electrical Characteristics} (\text{Note 8}) \\ \textbf{V}_{EE} = -4.2 \text{V to } -5.7 \text{V}, \ \textbf{V}_{CC} = \textbf{V}_{CCA} = \text{GND}, \ \textbf{T}_{C} = 0^{\circ}\text{C} \ \text{to } +85^{\circ}\text{C}, \ \textbf{C}_{L} = 50 \ \text{pF}, \ \textbf{V}_{TTL} = +4.5 \text{V to } +5.5 \text{V} \end{array}$

Symbol	Parameter	Min	Тур	Max	Units	Conditions
V <sub>OH</sub>	Output HIGH Voltage	2.7	3.1		V	$I_{OH} = -3 \text{ mA}, V_{TTL} = 4.75 \text{ V}$
		2.4	2.9		V	$I_{OH} = -3 \text{ mA}, V_{TTL} = 4.50 \text{V}$
V <sub>OL</sub>	Output LOW Voltage		0.3	0.5	V	I <sub>OL</sub> = 24 mA, V <sub>TTL</sub> = 4.50V
V <sub>IH</sub>	Input HIGH Voltage	-1165		-870	mV	Guaranteed HIGH Signal for All Inputs
V <sub>IL</sub>	Input LOW Voltage	-1830		-1475	mV	Guaranteed LOW Signal for All Inputs
I <sub>IH</sub>	Input HIGH Current			350	μΑ	V <sub>IN</sub> = V <sub>IH</sub> (Max)
I <sub>IL</sub>	Input LOW Current	0.50			μΑ	V <sub>IN</sub> = V <sub>IL</sub> (Min)
I <sub>OZHT</sub>	3-STATE Current Output HIGH			70	μΑ	$V_{OUT} = +2.7V$
I <sub>OZLT</sub>	3-STATE Current Output LOW	-700			μΑ	$V_{OUT} = +0.5V$
l <sub>os</sub>	Output Short-Circuit Current	-225		-100	mA	$V_{OUT} = 0.0V, V_{TTL} = +5.5V$
Ittl	V <sub>TTL</sub> Supply Current			74	mA	TTL Outputs LOW
				49	mA	TTL Outputs HIGH
				67	mA	TTL Outputs in 3-STATE

Note 8: The specified limits represent the "worst case" value for the parameter. Since these values normally occur at the temperature extremes, additional noise immunity and guardbanding can be achieved by decreasing the allowable system operating ranges. Conditions for testing shown in the tables are cho-sen to guarantee operation under "worst case" conditions.

### **DIP TTL-to-ECL AC Electrical Characteristics**

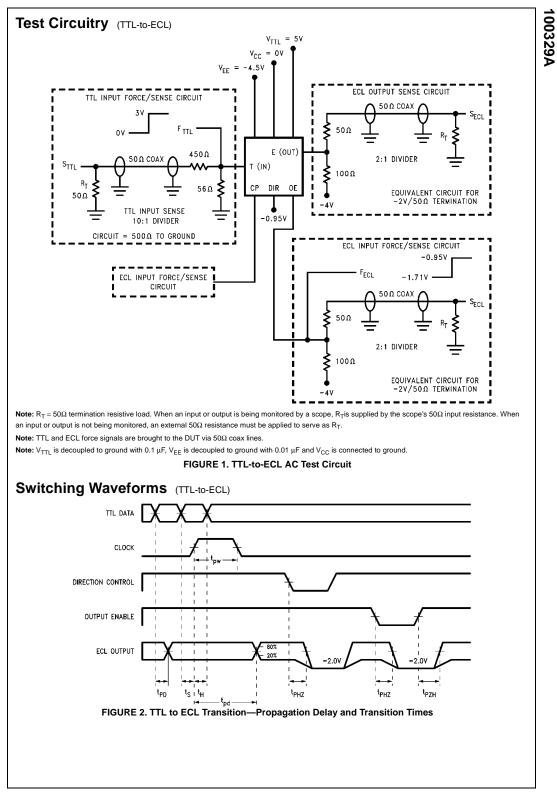
 $V_{FF} = -4.2V$  to -5.7V,  $V_{TTL} = +4.5V$  to +5.5V,  $V_{CC} = V_{CCA} = GND$ 

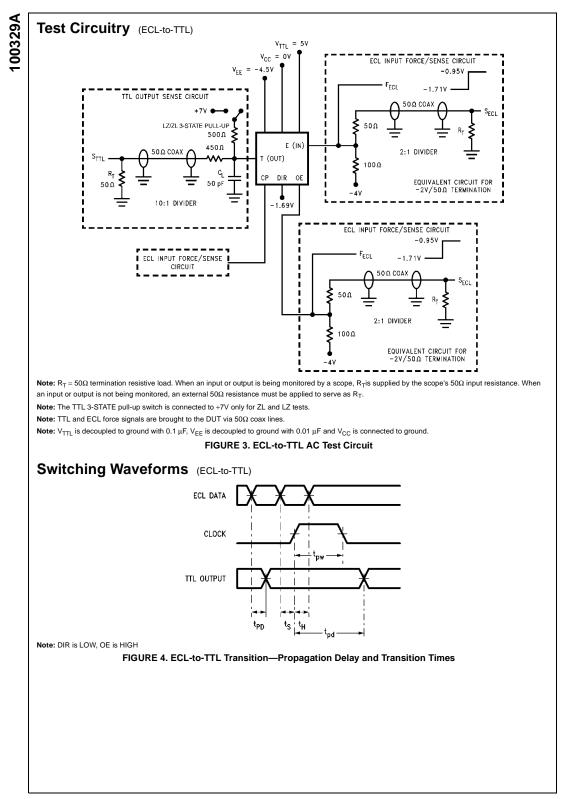
Symbol	Parameter	$\mathbf{T}_{\mathbf{C}} = 0^{\circ}\mathbf{C}$		T <sub>C</sub> =	$T_C = 25^{\circ}C$		T <sub>C</sub> = 85°C		Conditions
		Min	Max	Min	Max	Min	Max	Units	Conditions
f <sub>MAX</sub>	Max Toggle Frequency	350		350		350		MHz	
t <sub>PLH</sub>	CP to E <sub>n</sub>	1.7	3.6	1.7	3.7	1.9	3.9	ns	Figures 1, 2
t <sub>PHL</sub>									
t <sub>PZH</sub>	OE to E <sub>n</sub>	1.3	4.2	1.5	4.4	1.7	4.8	ns	Figures 1, 2
	(Cut-off to HIGH)	1.5	4.2	1.5	4.4	1.7	4.0	115	rigules 1, 2
t <sub>PHZ</sub> OE to E <sub>n</sub> (HIGH to Cut-off)	OE to E <sub>n</sub>	1.5	4.5	1.6	4.5	1.6	4.6	ns	Figures 1, 2
	(HIGH to Cut-off)	1.5	4.0	1.0	4.5	1.0	4.0	115	1 190165 1, 2
t <sub>PHZ</sub> DIR to E <sub>n</sub> (HIGH to Cut-off)	DIR to E <sub>n</sub>	1.6	4.3	1.6	4.3	1.7	4.5	ns	Figures 1, 2
	Cut-off)	4.5	1.0	4.5	1.7	4.5	115	Figures 1, 2	
t <sub>set</sub>	T <sub>n</sub> to CP	1.1		1.1		1.1		ns	Figures 1, 2
t <sub>hold</sub>	T <sub>n</sub> to CP	1.7		1.7		1.9		ns	Figures 1, 2
t <sub>pw</sub> (H)	Pulse Width CP	2.1		2.1		2.1		ns	Figures 1, 2
t <sub>TLH</sub>	Transition Time	0.6	1.6	0.6	1.6	0.6	1.6		Figures 1, 2
t <sub>THL</sub>	20% to 80%, 80% to 20%	0.6	1.0	0.6	1.0	0.6	1.0	ns	Figures 1, 2
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### **DIP ECL-to-TTL AC Electrical Characteristics**

 $V_{FF} = -4.2V$  to -5.7V,  $V_{TT1} = +4.5V$  to +5.5V,  $V_{CC} = V_{CCA} = GND$ ,  $C_1 = 50.pF$ 

Symbol	Parameter	$\mathbf{T_C} = 0^{\circ}\mathbf{C}$		$T_C = 25^{\circ}C$		$T_C = 85^\circ C$		Units	Conditions
		Min	Max	Min	Max	Min	Max	Units	conditions
MAX	Max Toggle Frequency	125		125		125		MHz	
PLH	CP to T <sub>n</sub>	3.1	7.2	3.1	7.2	3.3	7.7	ns	Figures 3, 4
PHL									
PZH	OE to T <sub>n</sub>	3.4	8.45	3.7	8.95	4.0	9.7	ns	Figures 3, 5
t <sub>PZL</sub>	(Enable Time)	3.8	9.2	4.0	9.2	4.3	9.95		
t <sub>PHZ</sub>	OE to T <sub>n</sub>	3.2	8.95	3.3	8.95	3.5	9.2	ns	Figures 3, 5
PLZ	(Disable Time)	3.0	7.7	3.4	8.7	4.1	9.95		
t <sub>PHZ</sub>	DIR to T <sub>n</sub>	2.7	8.2	2.8	8.7	3.1	8.95	ns	Figures 3, 6
PLZ	(Disable Time)	2.8	7.45	3.1	7.95	4.0	9.2	115	
set	E <sub>n</sub> to CP	1.1		1.1		1.1		ns	Figures 3, 4
t <sub>hold</sub>	E <sub>n</sub> to CP	2.1		2.1		2.6		ns	Figures 3, 4
t <sub>pw</sub> (H)	Pulse Width CP	4.1		4.1		4.1		ns	Figures 3, 4





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